



BSI Standards Publication

Printed electronics

Part 503-1: Quality assessment — Test method of displacement current measurement for printed thin-film transistor

National foreword

This British Standard is the UK implementation of IEC 62899-503-1:2020.

The UK participation in its preparation was entrusted to Technical Committee AMT/9, Printed Electronics.

A list of organizations represented on this committee can be obtained on request to its committee manager.

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